

MOS FIELD EFFECT TRANSISTOR μ PA1726

SWITCHING N-CHANNEL POWER MOS FET INDUSTRIAL USE

DESCRIPTION

The μ PA1726 is N-Channel MOS Field Effect Transistor designed for power management

★ applications of notebook computers and so on.

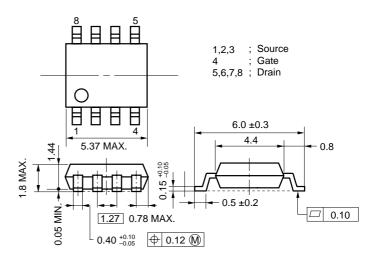
FEATURES

- + 2.5-V gate drive and low on-resistance $R_{DS(on)1}=9.1\ m\Omega\ MAX.\ (V{\rm GS}=4.5\ V,\ I{\rm D}=6.0\ A)$
- **★** $R_{DS(on)2} = 10.0 \text{ m}\Omega \text{ MAX.} (V_{GS} = 4.0 \text{ V}, I_D = 6.0 \text{ A})$
- ★ $R_{DS(on)3} = 12.5 \text{ m}\Omega \text{ MAX.} (V_{GS} = 2.5 \text{ V}, I_D = 6.0 \text{ A})$
 - Low Ciss: Ciss = 2700 pF TYP.
 - Built-in G-S protection diodes
 - Small and surface mount package (Power SOP8)

ORDERING INFORMATION

PART NUMBER	PACKAGE
μΡΑ1726G	Power SOP8

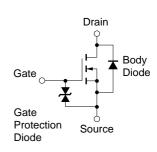
PACKAGE DRAWING (Unit : mm)



ABSOLUTE MAXIMUM RATINGS (TA = 25°C, All terminals are connected.)

Drain to Source Voltage (Vgs = 0 V)	VDSS	20	V
Gate to Source Voltage (VDS = 0 V)	Vgss	±12	V
Drain Current (DC)	D(DC)	±12	А
Drain Current (pulse) ^{Note1}	D(pulse)	±48	А
Total Power Dissipation $(T_A = 25^{\circ}C)^{Note2}$	Рт	2.0	W
Channel Temperature	Tch	150	°C
Storage Temperature	Tstg	-55 to +150	°C





Notes 1. PW \leq 10 μ s, Duty Cycle \leq 1 %

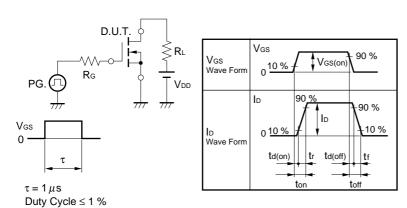
- 2. Mounted on ceramic substrate of 1200 mm² x 2.2 mm
- **Remark** The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

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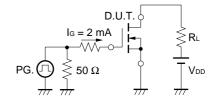
CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Drain to Source On-state Resistance	RDS(on)1	Vgs = 4.5 V, Id = 6.0 A		7.2	9.1	mΩ
	RDS(on)2	Vgs = 4.0 V, Id = 6.0 A		7.5	10.0	mΩ
	RDS(on)3	Vgs = 2.5 V, Id = 6.0 A		9.1	12.5	mΩ
Gate to Source Cut-off Voltage	VGS(off)	Vds = 10 V, Id = 1 mA	0.5	1.0	1.5	V
Forward Transfer Admittance	y _{fs}	Vds = 10 V, Id = 6.0 A	12	24		S
Drain Leakage Current	ldss	Vds = 20 V, Vgs = 0 V			10	μA
Gate to Source Leakage Current	lgss	$V_{GS} = \pm 12 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$			±10	μA
Input Capacitance	Ciss	V _{DS} = 10 V		2700		pF
Output Capacitance	Coss	V _{GS} = 0 V		880		pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		460		pF
Turn-on Delay Time	td(on)	ID = 6.0 A		50		ns
Rise Time	tr	$V_{GS(on)} = 4.5 V$		170		ns
Turn-off Delay Time	td(off)	Vdd = 10 V		100		ns
Fall Time	tr	R _G = 10 Ω		190		ns
Total Gate Charge	QG	ID = 12 A		25		nC
Gate to Source Charge	Qgs	Vdd = 16 V		4		nC
Gate to Drain Charge	Qgd	V _{GS} = 4.5 V		11		nC
Body Diode Forward Voltage	VF(S-D)	IF = 12 A, VGs = 0 V		0.8		V
Reverse Recovery Time	trr	IF = 12 A, VGs = 0 V		50		ns
Reverse Recovery Charge	Qrr	di/dt = 100 A/ μs		50		nC

ELECTRICAL CHARACTERISTICS (TA = 25 °C, All terminals are connected.)

TEST CIRCUIT 1 SWITCHING TIME



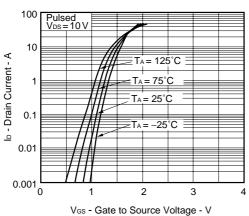
TEST CIRCUIT 2 GATE CHARGE

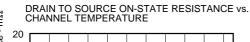


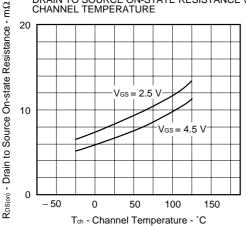


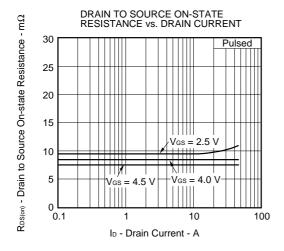
TYPICAL CHARACTERISTICS (TA = 25 °C, All terminals are connected.) *

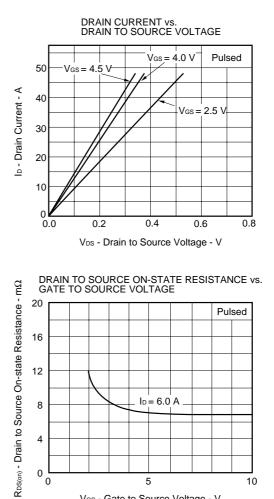
FORWARD TRANSFER CHARACTERISTICS

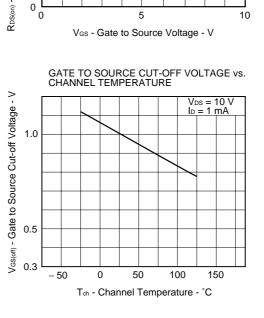




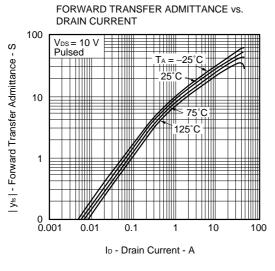






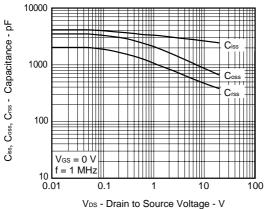


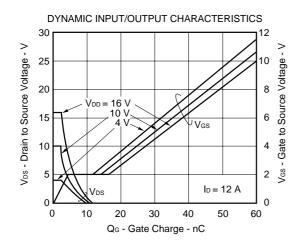
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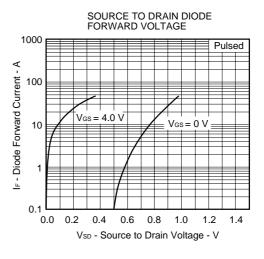


NEC

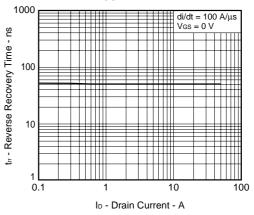


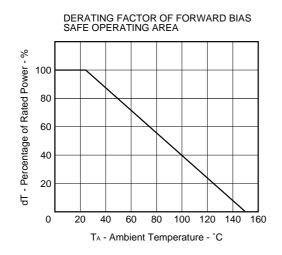




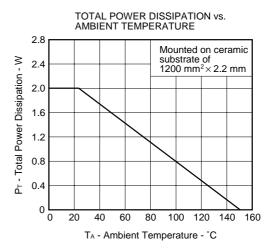


REVERSE RECOVERY TIME vs. DRAIN CURRENT

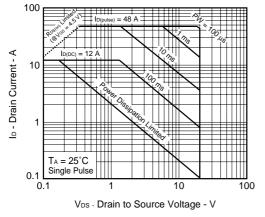




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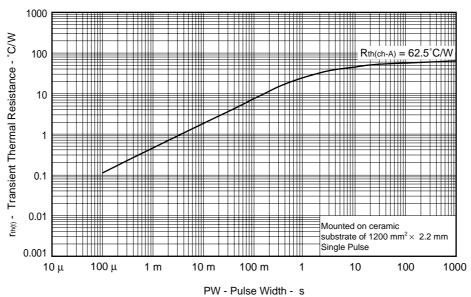


FORWARD BIAS SAFE OPERATING AREA



Remark

Mounted on ceramic substrate of 1200 $\text{mm}^2 \times 2.2 \text{ mm}$



TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH

Data Sheet G14050EJ1V0DS00

[MEMO]

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